XN09D58

Silicon PNP epitaxial planar type (Tr) Silicon epitaxial planar type (SBD)

For DC-DC converter

■ Features

- Two elements incorporated into one package (Tr + SBD)
- Reduction of the mounting area and assembly cost by one half
- Low collector-emitter saturation voltage V_{CE(sat)}

■ Basic Part Number

• XN9D57 + MA3ZD12

■ Absolute Maximum Ratings T_a = 25°C

	Parameter	Symbol	Rating	Unit
Tr	Collector-base voltage	V _{CBO}	-15	V
	(Emitter open)			
	Collector-emitter voltage	V _{CEO}	-15	V
	(Base open)			
	Emitter-base voltage	V _{EBO}	-5	V
	(Collector open)			i
	Collector current	I_{C}	-2.5	A
	Peak collector current	I_{CP}	-10	A
SBD	Reverse voltage	V _R	20	v
	Repetitive peak reverse voltage	V _{RRM}	25	V
	Forward current (Average)	$I_{F(AV)}$	700	mA
	Non-repetitive peak	I_{FSM}	2	A
	forward surge current	Jill's	6/0	412
Overall	Total power dissipation *	P_{T}	600	mW
	Junction temperature	T _j	125	°C
	Storage temperature	T_{stg}	-55 to +125	°C

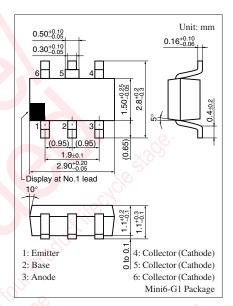
Note) *: Measuring on ceramic substrate at 15 mm \times 15 mm \times 0.6 mm

■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

• Tr

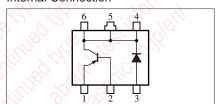
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_C = -10 \mu\text{A}, I_E = 0$	-15			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = -1 \text{ mA}, I_B = 0$	-15			V
Emitter-base voltage (Collector open)	V_{EBO}	$I_E = -10 \ \mu A, I_C = 0$	-5			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -10 \text{ V}, I_E = 0$			- 0.1	μΑ
Forward current transfer ratio *	h _{FE1}	$V_{CE} = -2 \text{ V}, I_{C} = -100 \text{ mA}$	200		560	_
	h _{FE2}	$V_{CE} = -2 \text{ V}, I_{C} = -2.5 \text{ A}$	100			
Collector-emitter saturation voltage *	V _{CE(sat)}	$I_C = -1 \text{ A}, I_B = -10 \text{ mA}$		-140		mV
		$I_C = -2.5 \text{ A}, I_B = -50 \text{ mA}$		-270	-320	

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.



Marking Symbol: EF

Internal Connection



^{2. *:} Pulse measurement

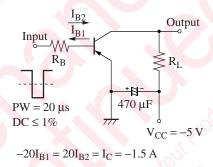
■ Electrical Characteristics (continued) $T_a = 25$ °C ± 3 °C

• Tr (continued)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		40		pF
(Common base, input open circuited)						
Transition frequency	f_T	$V_{CB} = -10 \text{ V}, I_E = 50 \text{ mA}, f = 200 \text{ MHz}$		180		MHz
Turn-on time	t _{on}	Refer to the switching time measurement circuit		35		ns
Storage time	t _{stg}			110		ns
Turn-off time	t _{off}			10		ns

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

Switching time measurement circuit



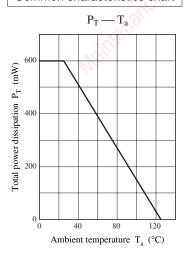
• SBD

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward voltage	$V_{\rm F}$	$I_F = 700 \text{ mA}$	000		0.45	V
Reverse current	I_R	$V_R = 20 \text{ V}$	34		200	μΑ
Terminal capacitance	C _t	$V_R = 0$, $f = 1$ MHz	S.	100	.16/	pF
Reverse recovery time	t _{rr}	$I_F = I_R = 100 \text{ mA}, I_{rr} = 10 \text{ mA}$	37 . 1	7	0,,	ns
		$R_{\rm I} = 100 \Omega$, ,(*	

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 Measuring methods for diodes.

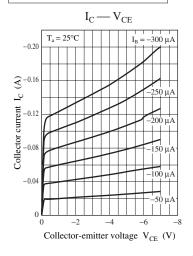
Schottky barrier diode is frail with static electricity, and it should be kept in safety from shock of static electricity and static electricity level.

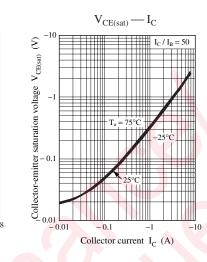
Common characteristics chart

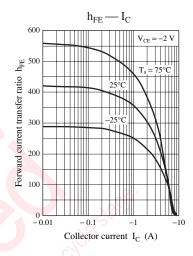


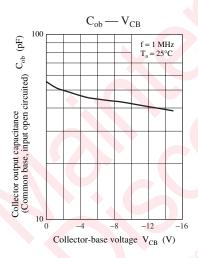
2 SJJ00246CED

Characteristics charts of Tr

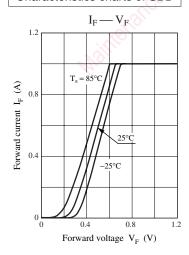


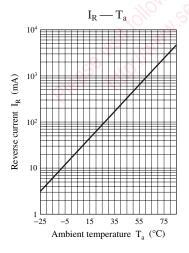


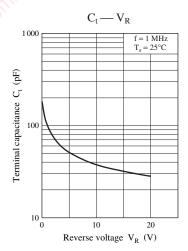




Characteristics charts of SBD







SJJ00246CED 3

Request for your special attention and precautions in using the technical information and semiconductors described in this book

- (1) If any of the products or technical information described in this book is to be exported or provided to non-residents, the laws and regulations of the exporting country, especially, those with regard to security export control, must be observed.
- (2) The technical information described in this book is intended only to show the main characteristics and application circuit examples of the products, and no license is granted under any intellectual property right or other right owned by our company or any other company. Therefore, no responsibility is assumed by our company as to the infringement upon any such right owned by any other company which may arise as a result of the use of technical information described in this book.
- (3) The products described in this book are intended to be used for standard applications or general electronic equipment (such as office equipment, communications equipment, measuring instruments and household appliances).

 Consult our sales staff in advance for information on the following applications:
 - Special applications (such as for airplanes, aerospace, automobiles, traffic control equipment, combustion equipment, life support systems and safety devices) in which exceptional quality and reliability are required, or if the failure or malfunction of the products may directly jeopardize life or harm the human body.
 - Any applications other than the standard applications intended.
- (4) The products and product specifications described in this book are subject to change without notice for modification and/or improvement. At the final stage of your design, purchasing, or use of the products, therefore, ask for the most up-to-date Product Standards in advance to make sure that the latest specifications satisfy your requirements.
- (5) When designing your equipment, comply with the range of absolute maximum rating and the guaranteed operating conditions (operating power supply voltage and operating environment etc.). Especially, please be careful not to exceed the range of absolute maximum rating on the transient state, such as power-on, power-off and mode-switching. Otherwise, we will not be liable for any defect which may arise later in your equipment.
- Even when the products are used within the guaranteed values, take into the consideration of incidence of break down and failure mode, possible to occur to semiconductor products. Measures on the systems such as redundant design, arresting the spread of fire or preventing glitch are recommended in order to prevent physical injury, fire, social damages, for example, by using the products.
- (6) Comply with the instructions for use in order to prevent breakdown and characteristics change due to external factors (ESD, EOS, thermal stress and mechanical stress) at the time of handling, mounting or at customer's process. When using products for which damp-proof packing is required, satisfy the conditions, such as shelf life and the elapsed time since first opening the packages.
- (7) This book may be not reprinted or reproduced whether wholly or partially, without the prior written permission of Matsushita Electric Industrial Co., Ltd.